# SILICON TRANSISTOR 2SC3356

# MICROWAVE LOW NOISE AMPLIFIER NPN SILICON EPITAXIAL TRANSISTOR

## DESCRIPTION

NEC

The 2SC3356 is an NPN silicon epitaxial transistor designed for low noise amplifier at VHF, UHF and CATV band.

It has dynamic range and good current characteristic.

#### FEATURES

Low Noise and High Gain

 $NF = 1.1 \ dB \ TYP., \ G_a = 11 \ dB \ TYP. \ @V_{CE} = 10 \ V, \ I_C = 7 \ mA, \ f = 1.0 \ GHz$   $\bullet \ High \ Power \ Gain$ 

MAG = 13 dB TYP. @Vce = 10 V, Ic = 20 mA, f = 1.0 GHz

#### ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

Collector to Base Voltage	Vсво	20	V
Collector to Emitter Voltage	Vceo	12	V
Emitter to Base Voltage	Vево	3.0	V
Collector Current	lc	100	mA
Total Power Dissipation	Рт	200	mW
Junction Temperature	Tj	150	°C
Storage Temperature	Tstg	-65 to +150	°C



#### ELECTRICAL CHARACTERISTICS (TA = 25 °C)

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Collector Cutoff Current	Ісво			1.0	μA	$V_{CB} = 10 V, I_E = 0$
Emitter Cutoff Current	Іево			1.0	μA	V <sub>EB</sub> = 1.0 V, Ic = 0
DC Current Gain	hfe*	50	120	300		Vce = 10 V, Ic = 20 mA
Gain Bandwidth Product	fт		7		GHz	Vce = 10 V, Ic = 20 mA
Feed-Back Capacitance	Cre**		0.55	1.0	pF	Vсв = 10 V, IE = 0, f = 1.0 MHz
Insertion Power Gain	S21e 2		11.5		dB	Vce = 10 V, Ic = 20 mA, f = 1.0 GHz
Noise Figure	NF		1.1	2.0	dB	Vce = 10 V, lc = 7 mA, f = 1.0 GHz

\* Pulse Measurement PW  $\leq$  350  $\mu$ s, Duty Cycle  $\leq$  2 %

\*\* The emitter terminal and the case shall be connected to the guard terminal of the three-terminal capacitance bridge.

#### **hFE Classification**

Class	R23/Q *	R24/R *	R25/S *
Marking	R23	R24	R25
hfe	50 to 100	80 to 160	125 to 250

\* Old Specification / New Specification

## TYPICAL CHARACTERISTICS (TA = 25 °C)





INSERTION GAIN vs. COLLECTOR CURRENT









#### **S-PARAMETER**

Vce = 10 V, Ic = 5 mA, Zo = 50  $\Omega$ 

f (MHz)	S11	∠ <b>S</b> 11	<b>S</b> <sub>21</sub>	∠ <b>S</b> 21	<b>S</b> 12	∠ <b>S</b> 12	<b>S</b> 22	∠ <b>S</b> 22
200	0.651	-69.3	10.616	129.3	0.051	59.2	0.735	-28.1
400	0.467	-113.3	6.856	104.4	0.071	54.4	0.550	-34.1
600	0.391	-139.3	4.852	90.9	0.086	56.0	0.468	-33.9
800	0.360	-159.2	3.802	81.2	0.101	59.1	0.426	-33.6
1000	0.360	-176.9	3.098	72.9	0.118	61.0	0.397	-35.7
1200	0.361	172.7	2.646	67.3	0.137	63.5	0.373	-38.3
1400	0.381	160.3	2.298	59.3	0.157	63.3	0.360	-43.0
1600	0.398	152.2	2.071	55.2	0.180	64.1	0.337	-45.9
1800	0.423	143.3	1.836	49.0	0.203	63.7	0.320	-52.3
2000	0.445	137.6	1.689	46.2	0.220	64.7	0.302	-52.2

#### $V_{CE}$ = 10 V, Ic = 5 mA, Zo = 50 $\Omega$

f (MHz)	S11	∠ <b>S</b> 11	<b>S</b> 21	∠ <b>S</b> 21	<b>S</b> 12	∠ <b>S</b> 12	S22	∠ <b>S</b> 22
200	0.339	-107.0	16.516	108.7	0.035	66.1	0.459	-36.6
400	0.258	-147.3	8.928	92.1	0.060	71.0	0.343	-32.9
600	0.243	-167.7	6.022	83.0	0.085	71.9	0.305	-29.9
800	0.242	177.0	4.633	76.2	0.109	72.2	0.284	-29.4
1000	0.260	164.5	3.744	69.9	0.136	70.4	0.266	-31.7
1200	0.269	157.6	3.193	65.7	0.160	69.9	0.246	-35.0
1400	0.294	148.7	2.750	58.8	0.187	66.7	0.233	-40.4
1600	0.314	143.1	2.479	55.5	0.212	65.2	0.208	-43.6
1800	0.343	136.5	2.185	50.1	0.238	62.4	0.190	-50.5
2000	0.367	131.4	2.016	47.8	0.254	61.6	0.173	-48.3

# S-PARAMETER



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Anti-radioactive design is not implemented in this product.

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